## Notice of References Cited Application/Control No. 10/648,252 Examiner Kevin Verbrugge Applicant(s)/Patent Under Reexamination KIMURA ET AL. Page 1 of 1

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	Α	US-2005/0021727	01-2005	Matsunami et al.	709/223
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	D	US-			
	Е	US-			
	F	US-			
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